A Full Power Emulation Platform for Evaluating Power Semiconductors



$i_L(t) = $	$\frac{\partial C}{\partial t} \cdot \frac{duty}{2 \cdot freq} + \frac{V_{DC}}{L_1} \cdot t if \ 0 \le t \le \frac{duty}{freq}$	$\left\{ V_{DC} if \ 0 \leq \right.$	
	$\frac{V_{DC}}{L_1} \cdot \frac{duty}{2 \cdot freq} \qquad if \frac{duty}{freq} < t \le \frac{1}{2 \cdot freq}$	$\begin{cases} \frac{1}{2 \cdot freq} \\ if \frac{1}{2 \cdot freq} \le t \le \frac{2 \cdot duty + 1}{2 \cdot freq} \\ t \le \frac{1}{freq} \end{cases} \qquad V_{bridge}(t) = \begin{cases} \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\$	0 if $\frac{d}{dt}$
	$\frac{V_{DC}}{L_1} \cdot \frac{duty}{2 \cdot freq} - \frac{V_{DC}}{L_1} \cdot (t - \frac{1}{2 \cdot freq}) if \frac{1}{2 \cdot freq} \le t \le \frac{2 \cdot duty + 1}{2 \cdot freq}$		$-V_{DC}$ if $\frac{1}{2}$
	$\left(-\frac{V_{DC}}{L_1} \cdot \frac{duty}{2 \cdot freq} if \ \frac{2 \cdot duty + 1}{2 \cdot freq} \le t \le \frac{1}{freq}\right)$		$\begin{bmatrix} 0 & if \ \frac{2 \cdot dut}{2 \cdot ft} \end{bmatrix}$





ZVS transition of a half bridge power stage

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Device Modeling with Proposed Platform Yokogawa WT1800 Power Meter DC Power Supply Power measured by power meter = Magnetic loss + Transistor Loss + other loss 7kW Inductor DUT: two GaN Half Bridege IMS Modules **Full Power Emulation Platform and Device Under Test**





Conclusion

The operation principles of the full-bridge energy recirculation and storage circuit are explored and extended to evaluate power semiconductors under both soft switching and hard switching conditions. An IMS-based 120 A/ 650 V GaN power module is evaluated by proposed full power emulation platform. A strong correlation has been shown between simulation and experiment results under all test conditions.

